



LD1117/A

LINEAR INTEGRATED CIRCUIT

LOW DROP FIXED AND ADJUSTABLE POSITIVE VOLTAGE REGULATORS

DESCRIPTION

The UTC LD1117/A is a low dropout, 3-terminals positive voltage regulator designed to provide output current up to 800mA/1A, even available in adjustable version ($V_{REF}=1.25V$) and various fixed versions. Diverse surface mount packages optimize the thermal characteristics even offering a relevant space saving effect.

High efficiency is assured by NPN pass transistor. In fact, in the case, unlike than PNP one, the Quiescent Current flows mostly into the load. Only a very common $10\mu F$ minimum capacitor is needed for stability. It allows very tight output voltage tolerance within $\pm 1\%$ at $25^\circ C$ by chip trim. Moreover, the ADJUSTABLE version is pin to pin compatible with the other standard Adjustable voltage regulators maintaining the better performances in terms of Drop and Tolerance.

FEATURES

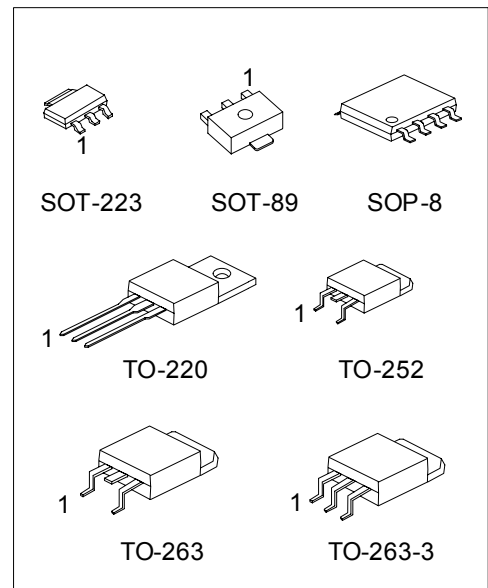
- *Low dropout voltage (1V Typ.)
- *2.85V device performances are suitable for SCSI-2 active termination
- *Output current up to 0.8A/1.0A
- *Adjustable version availability ($V_{REF}=1.25V$)
- *Internal current and thermal limit.
- *Available in $\pm 1\%$ (at $25^\circ C$) and 2% in all temperature range
- *Supply voltage rejection: 75dB (Typ.)

ORDERING INFORMATION

Order Number		Package	② Pin Assignment	③ Packing
Normal	Lead Free Plating			
LD1117①-xx-AA3-②-③	LD1117①L-xx-AA3-②-③	SOT-223	A: GOI B: OGI C: GIO D: IGO	R: Tape Reel T: Tube
LD1117①-xx-AB3-②-③	LD1117①L-xx-AB3-②-③	SOT-89		
LD1117①-xx-TA3-②-③	LD1117①L-xx-TA3-②-③	TO-220		
LD1117①-xx-TN3-②-③	LD1117①L-xx-TN3-②-③	TO-252		
LD1117①-xx-TQ2-②-③	LD1117①L-xx-TQ2-②-③	TO-263		
LD1117①-xx-TQ3-②-③	LD1117①L-xx-TQ3-②-③	TO-263-3		
LD1117①-xx-S08-③	LD1117①L-xx-S08-③	SOP-8	GOOIxOOx	

Note: Pin Assignment: I: V_{IN} O: V_{OUT} G: GND

<p>LD1117①L-xx-AA3-②-③</p>	<p>(1) Packing Type (2) Pin Assignment (3) Package Type (4) Output Voltage Code (5) Lead Plating (6) Current Code</p>
	<p>(1) R: Tape Reel (2) refer to Pin Assignment (3) AA3: SOT-223, AB3: SOT-89, TA3: TO-220, TN 3: TO-252, TQ2: TO-263, TQ3: TO-263-3, S08: SOT-8 (4) xx: refer to Marking Information (5) L: Lead Free Plating, Blank: Pb/Sn (6) Blank: 800mA, A: 1A</p>



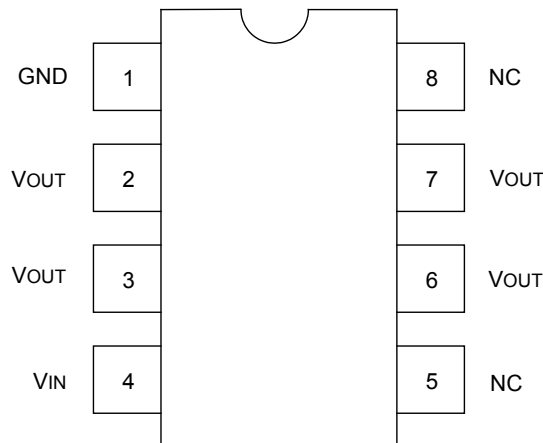
*Pb-free plating product number:
LD1117L-xx / LD1117AL-xx

MARKING INFORMATION

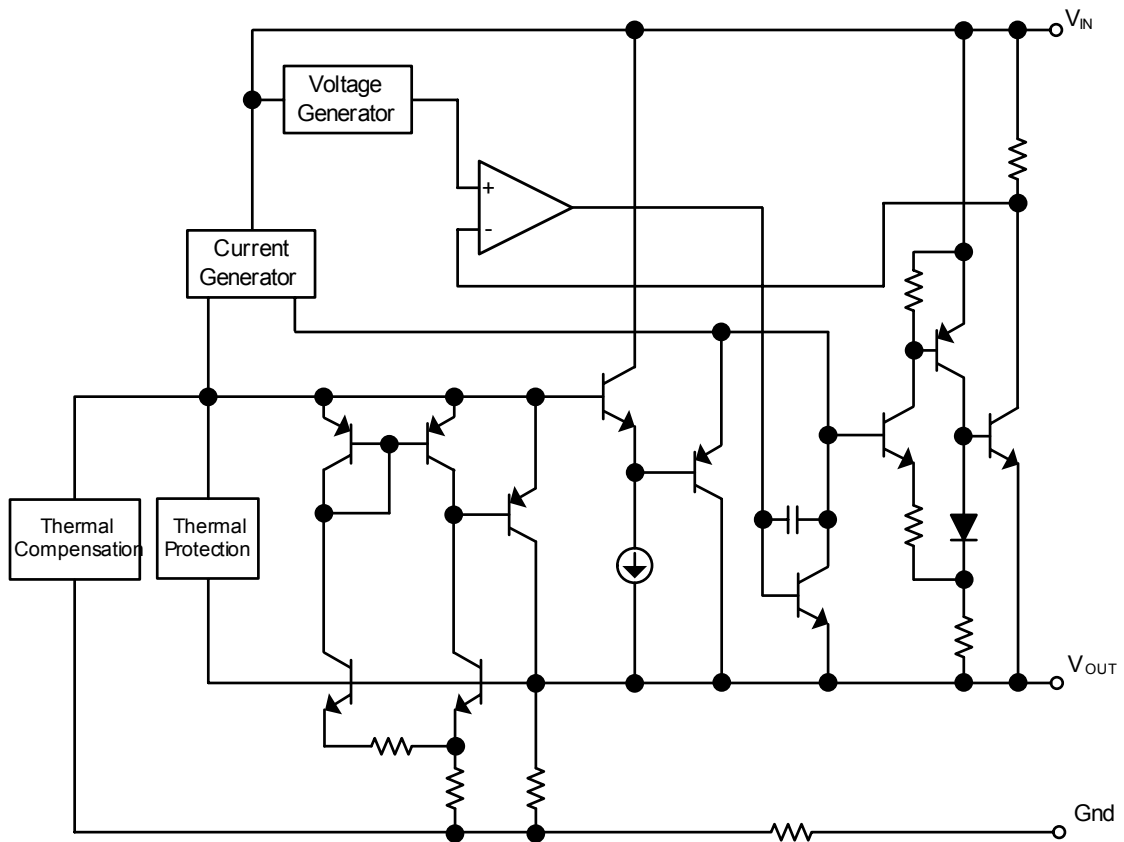
PACKAGE	VOLTAGE CODE	MARKING
SOT-89		
SOT-223	12 : 1.2V 15 : 1.5V 18 : 1.8V 25 : 2.5V 2J : 2.85V 30 : 3.0V 33 : 3.3V 36 : 3.6V 50 : 5.0V AD : ADJ	
TO-220 TO-252 TO-263 TO-263-3		

Note: Current code: Blank: 0.8A A: 1A

PIN CONFIGURATION



■ BLOCK DIAGRAM



■ ABSOLUTE MAXIMUM RATINGS (Ta=25°C)

PARAMETER	SYMBOL	RATINGS	UNIT
DC Input Voltage	V _{IN}	15	V
Power Dissipation	P _D	Internally limited	
Operating Junction Temperature	T _J	0 ~ +125	°C
Storage temperature	T _{STG}	-65 ~ +150	°C

Note Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ ELECTRICAL CHARACTERISTICS

(Ta=25°C, refer to the test circuits, T_J=0 to 125°C, Co=10μF unless otherwise specified)

For LD1117/A-1.2

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V _{OUT}	V _{IN} =3.2V, I _{OUT} =10mA, T _J =25°C	1.188	1.200	1.212	V
Output Voltage	V _{OUT}	V _{IN} =2.7 to 8V LD1117 : I _{OUT} =0 ~ 800mA LD1117A : I _{OUT} =0 ~ 1.0A	1.176	1.200	1.224	V
Line Regulation	ΔV _{OUT}	V _{IN} =2.7 to 8V, I _{OUT} =0mA		1	6	mV
Load Regulation	ΔV _{OUT}	V _{IN} =2.7V LD1117 : I _{OUT} =0 ~ 800mA LD1117A : I _{OUT} =0 ~ 1000mA		1	10	mV
Temperature stability	ΔV _{OUT}			0.5		%
Long Term Stability	ΔV _{OUT}	1000 hrs, T _J =125°C		0.3		%
Operating Input Voltage	V _{IN}	I _{OUT} =100mA			15	V
Quiescent Current	I _Q	V _{IN} ≤10V		5	10	mA
Current Limit	I _{LIMIT}	V _{IN} =6.2V, T _J =25°C	LD1117	800		mA
			LD1117A	1000		
Minimum Load Current	I _{O(MIN)}	V _{IN} =15V		2	5	mA
Output Noise Voltage	e _N	B=10Hz to 10KHz, T _J =25°C		100		μV
Supply Voltage Rejection	SVR	I _{OUT} =40mA, f=120Hz, T _J =25°C, V _{IN} =4.2V, V _{RIPPLE} =1Vpp	60	75		dB
Dropout Voltage	V _D	I _{OUT} =100mA I _{OUT} =500mA I _{OUT} =800mA I _{OUT} =1000 mA		1.00	1.10	V
				1.15	1.25	V
				1.20	1.30	V
				1.20	1.30	V
Thermal Regulation		Ta=25°C, 30ms Pulse		0.01	0.10	%/W

■ ELECTRICAL CHARACTERISTICS(Cont.)

For LD1117/A-1.5

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V_{OUT}	$V_{IN}=3.5V, I_{OUT}=10mA, T_J=25^{\circ}C$	1.485	1.500	1.515	V
Output Voltage	V_{OUT}	$V_{IN}=3$ to 8V LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1.0A$	1.470	1.500	1.530	V
Line Regulation	ΔV_{OUT}	$V_{IN}=3$ to 8V, $I_{OUT}=0mA$		1	6	mV
Load Regulation	ΔV_{OUT}	$V_{IN}=3V$ LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1000mA$		1	10	mV
Temperature stability	ΔV_{OUT}			0.5		%
Long Term Stability	ΔV_{OUT}	1000 hrs, $T_J=125^{\circ}C$		0.3		%
Operating Input Voltage	V_{IN}	$I_{OUT}=100mA$			15	V
Quiescent Current	I_Q	$V_{IN} \leq 10V$		5	10	mA
Current Limit	I_{LIMIT}	$V_{IN}=6.5V, T_J=25^{\circ}C$	LD1117	800		mA
			LD1117A	1000		
Output Noise Voltage	eN	B=10Hz to 10KHz, $T_J=25^{\circ}C$		100		μV
Supply Voltage Rejection	SVR	$I_{OUT}=40mA, f=120Hz, T_J=25^{\circ}C,$ $V_{IN}=4.5V, V_{RIPPLE}=1V_{pp}$	60	75		dB
Dropout Voltage	V_D		$I_{OUT}=100mA$	1.00	1.10	V
			$I_{OUT}=500mA$	1.15	1.25	V
			$I_{OUT}=800mA$	1.20	1.30	V
			$I_{OUT}=1000 mA$	1.20	1.30	V
Thermal Regulation		$T_a=25^{\circ}C, 30ms$ Pulse		0.01	0.10	%/W

For LD1117/A-1.8

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V_{OUT}	$V_{IN}=3.8V, I_{OUT}=10mA, T_J=25^{\circ}C$	1.780	1.800	1.820	V
Output Voltage	V_{OUT}	$V_{IN}=3.3$ to 8V LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1000mA$	1.760	1.800	1.840	V
Line Regulation	ΔV_{OUT}	$V_{IN}=3.3$ to 8V, $I_{OUT}=0mA$		1	6	mV
Load Regulation	ΔV_{OUT}	$V_{IN}=3.3V$ LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1000mA$		1	10	mV
Temperature stability	ΔV_{OUT}			0.5		%
Long Term Stability	ΔV_{OUT}	1000 hrs, $T_J=125^{\circ}C$		0.3		%
Operating Input Voltage	V_{IN}	$I_{OUT}=100mA$			10	V
Quiescent Current	I_Q	$V_{IN} \leq 8V$		5	10	mA
Current Limit	I_{LIMIT}	$V_{IN}=6.8V, T_J=25^{\circ}C$	LD1117	800		mA
			LD1117A	1000		
Output Noise Voltage	eN	B=10Hz to 10KHz, $T_J=25^{\circ}C$		100		μV
Supply Voltage Rejection	SVR	$I_{OUT}=40mA, f=120Hz, T_J=25^{\circ}C,$ $V_{IN}=5.5V, V_{RIPPLE}=1V_{pp}$	60	75		dB
Dropout Voltage	V_D		$I_{OUT}=100mA$	1.00	1.10	V
			$I_{OUT}=500mA$	1.15	1.25	V
			$I_{OUT}=800mA$	1.20	1.30	V
			$I_{OUT}=1000 mA$	1.20	1.30	V
Thermal Regulation		$T_a=25^{\circ}C, 30ms$ Pulse		0.01	0.10	%/W

■ ELECTRICAL CHARACTERISTICS(Cont.)

For LD1117/A-2.5

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Output Voltage	V_{OUT}	$V_{IN}=4.5V, I_{OUT}=10mA, T_J=25^{\circ}C$	1%	2.475	2.500	2.525	V
			2%	2.450	2.500	2.550	
Output Voltage	V_{OUT}	$V_{IN}=3.9$ to 10V LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1.0A$	2%	2.450	2.500	2.550	V
			4%	2.400	2.500	2.600	
Line Regulation	ΔV_{OUT}	$V_{IN}=3.9$ to 10V, $I_{OUT}=0mA$		1	6	mV	
Load Regulation	ΔV_{OUT}	$V_{IN}=3.9V$ LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1000mA$		1	10	mV	
Temperature stability	ΔV_{OUT}			0.5		%	
Long Term Stability	ΔV_{OUT}	1000 hrs, $T_J = 125^{\circ}C$		0.3		%	
Operating Input Voltage	V_{IN}	$I_{OUT}=100mA$			15	V	
Quiescent Current	I_Q	$V_{IN} \leq 10V$		5	10	mA	
Current Limit	I_{LIMIT}	$V_{IN}=7.5V, T_J = 25^{\circ}C$	LD1117	800			mA
			LD1117A	1000			
Output Noise Voltage	eN	B=10Hz to 10KHz, $T_J = 25^{\circ}C$		100		μV	
Supply Voltage Rejection	SVR	$I_{OUT}=40mA, f=120Hz, T_J = 25^{\circ}C, V_{IN}=5.5V, V_{ripple}=1V_{pp}$	60	75		dB	
Dropout Voltage	V_D	$I_{OUT}=100mA$ $I_{OUT}=500mA$ $I_{OUT}=800mA$ $I_{OUT}=1000mA$		1.00	1.10	V	
				1.15	1.25	V	
				1.20	1.30	V	
				1.20	1.30	V	
Thermal Regulation		$T_a=25^{\circ}C, 30ms$ Pulse		0.01	0.10	%/W	

For LD1117/A-2.85

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Output Voltage	V_{OUT}	$V_{IN}=4.85V, I_{OUT}=10mA, T_J = 25^{\circ}C$	2.828	2.850	2.880	V	
Output Voltage	V_{OUT}	$V_{IN}=4.25$ to 10V LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1.0A$	2.790	2.850	2.910	V	
Line Regulation	ΔV_{OUT}	$V_{IN}=4.25$ to 10V, $I_{OUT}=0mA$		1	6	mV	
Load Regulation	ΔV_{OUT}	$V_{IN}=4.25V$ LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1000mA$		1	10	mV	
Temperature stability	ΔV_{OUT}			0.5		%	
Long Term Stability	ΔV_{OUT}	1000 hrs, $T_J = 125^{\circ}C$		0.3		%	
Operating Input Voltage	V_{IN}	$I_{OUT}=100mA$			15	V	
Quiescent Current	I_Q	$V_{IN} \leq 10V$		5	10	mA	
Current Limit	I_{LIMIT}	$V_{IN}=7.85V, T_J = 25^{\circ}C$	LD1117	800			mA
			LD1117A	1000			
Output Noise Voltage	eN	B=10Hz to 10KHz, $T_J = 25^{\circ}C$		100		μV	
Supply Voltage Rejection	SVR	$I_{OUT}=40mA, f=120Hz, T_J = 25^{\circ}C, V_{IN}=5.85V, V_{ripple}=1V_{pp}$	60	75		dB	
Dropout Voltage	V_D	$I_{OUT}=100mA$ $I_{OUT}=500mA$ $I_{OUT}=800mA$ $I_{OUT}=1000mA$		1.00	1.10	V	
				1.15	1.25	V	
				1.20	1.30	V	
				1.20	1.30	V	
Thermal Regulation		$T_a=25^{\circ}C, 30ms$ Pulse		0.01	0.10	%/W	

■ ELECTRICAL CHARACTERISTICS(Cont.)

For LD1117/A-3.0

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Output Voltage	V _{OUT}	V _{IN} =5V, I _{OUT} =10mA, T _J =25°C	1%	2.970	3.000	3.030	V
			2%	2.940	3.000	3.060	
Output Voltage	V _{OUT}	V _{IN} =4.5 to 10V LD1117 : I _{OUT} =0 ~ 800mA LD1117A : I _{OUT} =0 ~ 1.0A	2%	2.940	3.000	3.060	V
			4%	2.880	3.000	3.120	
Line Regulation	ΔV _{OUT}	V _{IN} =4.5 to 12V, I _{OUT} =0mA		1	6	mV	
Load Regulation	ΔV _{OUT}	V _{IN} =4.5V LD1117 : I _{OUT} =0 ~ 800mA LD1117A : I _{OUT} =0 ~ 1000mA		1	10	mV	
Temperature stability	ΔV _{OUT}			0.5		%	
Long Term Stability	ΔV _{OUT}	1000 hrs, T _J =125°C		0.3		%	
Operating Input Voltage	V _{IN}	I _{OUT} =100mA			15	V	
Quiescent Current	I _Q	V _{IN} ≤10V		5	10	mA	
Current Limit	I _{LIMIT}	V _{IN} =8V, T _J =25°C	LD1117	800			mA
			LD1117A	1000			
Output Noise Voltage	eN	B=10Hz to 10KHz, T _J =25°C		100		μV	
Supply Voltage Rejection	SVR	I _{OUT} =40mA, f=120Hz, T _J =25°C, V _{IN} =6V, V _{RIPPLE} =1Vpp	60	75		dB	
Dropout Voltage	V _D	I _{OUT} =100mA I _{OUT} =500mA I _{OUT} =800mA I _{OUT} =1000 mA		1.00	1.10	V	
				1.15	1.25	V	
				1.20	1.30	V	
				1.20	1.30	V	
Thermal Regulation		T _a =25°C, 30ms Pulse		0.01	0.10	%/W	

For LD1117/A-3.3

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Output Voltage	V _{OUT}	V _{IN} =5.3V, I _{OUT} =10mA, T _J =25°C	1%	3.267	3.300	3.333	V
			2%	3.235	3.300	3.365	
Output Voltage	V _{OUT}	V _{IN} =4.75 to 10V LD1117 : I _{OUT} =0 ~ 800mA LD1117A : I _{OUT} =0 ~ 1.0A	2%	3.235	3.300	3.365	V
			4%	3.160	3.300	3.440	
Line Regulation	ΔV _{OUT}	V _{IN} =4.75 to 15V, I _{OUT} =0mA		1	6	mV	
Load Regulation	ΔV _{OUT}	V _{IN} =4.75V LD1117 : I _{OUT} =0 ~ 800mA LD1117A : I _{OUT} =0 ~ 1000mA		1	10	mV	
Temperature stability	ΔV _{OUT}			0.5		%	
Long Term Stability	ΔV _{OUT}	1000 hrs, T _J =125°C		0.3		%	
Operating Input Voltage	V _{IN}	I _{OUT} =100mA			15	V	
Quiescent Current	I _Q	V _{IN} ≤15V		5	10	mA	
Current Limit	I _{LIMIT}	V _{IN} =8.3V, T _J =25°C	LD1117	800			mA
			LD1117A	1000			
Output Noise Voltage	eN	B=10Hz to 10KHz, T _J =25°C		100		μV	
Supply Voltage Rejection	SVR	I _{OUT} =40mA, f=120Hz, T _J =25°C, V _{IN} =6.3V, V _{RIPPLE} =1Vpp	60	75		dB	
Dropout Voltage	V _D	I _{OUT} =100mA I _{OUT} =500mA I _{OUT} =800mA I _{OUT} =1000 mA		1.00	1.10	V	
				1.15	1.25	V	
				1.20	1.30	V	
				1.20	1.30	V	
Thermal Regulation		T _a =25°C, 30ms Pulse		0.01	0.10	%/W	

■ ELECTRICAL CHARACTERISTICS(Cont.)

For LD1117/A-3.6

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Output Voltage	V_{OUT}	$V_{IN}=5.6V, I_{OUT}=10mA, T_J=25^{\circ}C$	3.564	3.600	3.636	V
Output Voltage	V_{OUT}	$V_{IN}=5$ to 10V LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1.0A$	3.528	3.600	3.672	V
Line Regulation	ΔV_{OUT}	$V_{IN}=5$ to 15V, $I_{OUT}=0mA$		1	6	mV
Load Regulation	ΔV_{OUT}	$V_{IN}=5V$ LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1000mA$		1	10	mV
Temperature stability	ΔV_{OUT}			0.5		%
Long Term Stability	ΔV_{OUT}	1000 hrs, $T_J=125^{\circ}C$		0.3		%
Operating Input Voltage	V_{IN}	$I_{OUT}=100mA$			15	V
Quiescent Current	I_Q	$V_{IN} \leq 15V$		5	10	mA
Current Limit	I_{LIMIT}	$V_{IN}=8.6V, T_J=25^{\circ}C$	LD1117	800		mA
			LD1117A	1000		
Output Noise Voltage	eN	B=10Hz to 10KHz, $T_J=25^{\circ}C$		100		μV
Supply Voltage Rejection	SVR	$I_{OUT}=40mA, f=120Hz, T_J=25^{\circ}C,$ $V_{IN}=6.6V, V_{RIPPLE}=1V_{pp}$	60	75		dB
Dropout Voltage	V_D	$I_{OUT}=100mA$ $I_{OUT}=500mA$ $I_{OUT}=800mA$ $I_{OUT}=1000mA$		1.00	1.10	V
				1.15	1.25	V
				1.20	1.30	V
				1.20	1.30	V
Thermal Regulation		$T_a=25^{\circ}C, 30ms$ Pulse		0.01	0.10	%/W

For LD1117/A-5.0

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Output Voltage	V_{OUT}	$V_{IN}=7V, I_{OUT}=10mA, T_J=25^{\circ}C$	1%	4.950	5.000	5.050	V
			2%	4.900	5.000	5.100	
Output Voltage	V_{OUT}	$V_{IN}=6.5$ to 15V LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1.0A$	2%	4.900	5.000	5.100	V
			4%	4.800	5.000	5.200	
Line Regulation	ΔV_{OUT}	$V_{IN}=6.5$ to 15V, $I_{OUT}=0mA$		1	6	mV	
Load Regulation	ΔV_{OUT}	$V_{IN}=6.5V$ LD1117 : $I_{OUT}=0 \sim 800mA$ LD1117A : $I_{OUT}=0 \sim 1000mA$		1	10	mV	
Temperature stability	ΔV_{OUT}			0.5		%	
Long Term Stability	ΔV_{OUT}	1000 hrs, $T_J=125^{\circ}C$		0.3		%	
Operating Input Voltage	V_{IN}	$I_{OUT}=100mA$			15	V	
Quiescent Current	I_Q	$V_{IN} \leq 15V$		5	10	mA	
Current Limit	I_{LIMIT}	$V_{IN}=10V, T_J=25^{\circ}C$	LD1117	800		mA	
			LD1117A	1000			
Output Noise Voltage	eN	B=10Hz to 10KHz, $T_J=25^{\circ}C$		100		μV	
Supply Voltage Rejection	SVR	$I_{OUT}=40mA, f=120Hz, T_J=25^{\circ}C,$ $V_{IN}=8V, V_{RIPPLE}=1V_{pp}$	60	75		dB	
Dropout Voltage	V_D	$I_{OUT}=100mA$ $I_{OUT}=500mA$ $I_{OUT}=800mA$ $I_{OUT}=1000mA$		1.00	1.10	V	
				1.15	1.25	V	
				1.20	1.30	V	
				1.20	1.30	V	
Thermal Regulation		$T_a=25^{\circ}C, 30ms$ Pulse		0.01	0.10	%/W	

■ ELECTRICAL CHARACTERISTICS(Cont.)

For LD1117/A-ADJUSTABLE

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Reference Voltage	V _{REF}	V _{IN} -V _{OUT} =2V, I _{OUT} =10mA, T _J =25°C	1.238	1.25	1.262	V
Reference Voltage	V _{REF}	V _{IN} -V _{OUT} =1.4 to 10V LD1117 : I _{OUT} =10 ~ 800mA LD1117A : I _{OUT} =10 ~ 1000mA	1.225		1.275	V
Line Regulation	ΔV _{OUT}	V _{IN} -V _{OUT} =1.5 to 13.75V, I _{OUT} =10mA		0.035	0.200	%
Load Regulation	ΔV _{OUT}	V _{IN} -V _{OUT} =3V LD1117 : I _{OUT} =10 ~ 800mA LD1117A : I _{OUT} =10 ~ 1000mA		0.10	0.400	%
Temperature stability	ΔV _{OUT}			0.50		%
Long Term Stability	ΔV _{OUT}	1000 hrs, T _J =125°C		0.3		%
Operating Input Voltage	V _{IN}				15	V
Adjustment Pin Current	I _{ADJ}	V _{IN} ≤15V		60	120	μA
Adjustment Pin Current Change	ΔI _{ADJ}	V _{IN} -V _{OUT} =1.4 to 10V, LD1117 : I _{OUT} =10 ~ 800mA LD1117A : I _{OUT} =10 ~ 1000mA		1	5	μA
Minimum Load Current	I _{O(MIN)}	V _{IN} =15V		2	5	mA
Current Limit	I _{LIMIT}	V _{IN} -V _{OUT} =5V, T _J =25°C	LD1117	800		mA
			LD1117A	1000		
Output Noise (%Vo)	eN	B=10Hz to 10KHz, T _J =25°C		0.003		%
Supply Voltage Rejection	SVR	I _{OUT} =40mA, f=120Hz, T _J =25°C, V _{IN} -V _{OUT} =3V, V _{ripple} =1Vpp	60	75		dB
Dropout Voltage	V _D	I _{OUT} =100mA I _{OUT} =500mA I _{OUT} =800mA I _{OUT} =1000mA		1.00	1.10	V
				1.15	1.25	V
				1.20	1.30	V
				1.20	1.30	V
Thermal Regulation		T _a =25°C, 30ms Pulse		0.01	0.10	%/W

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Thermal Resistance Junction-Case	θ _{JC}	SOT-223	15
		SOP-8	20
		TO-252	12
		TO-220	4
		TO-263	4
Thermal Resistance Junction-Ambient	θ _{JA}	SOT-223	165
		SOP-8	150
		TO-252	112
		TO-220	54
		TO-263	64

■ TYPICAL APPLICATIONS

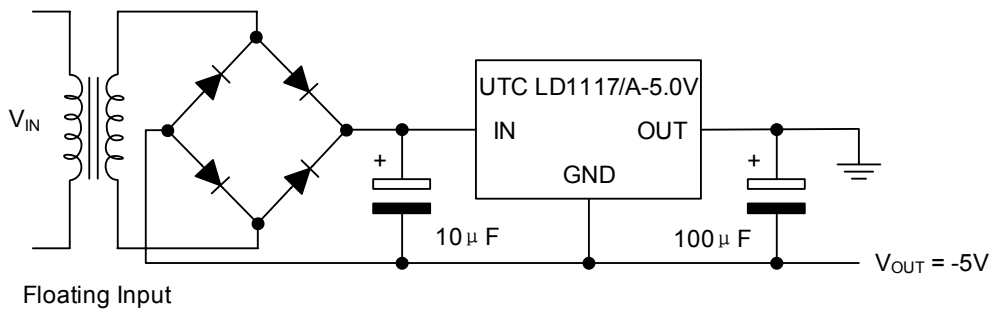


FIG.1 Negative Supply

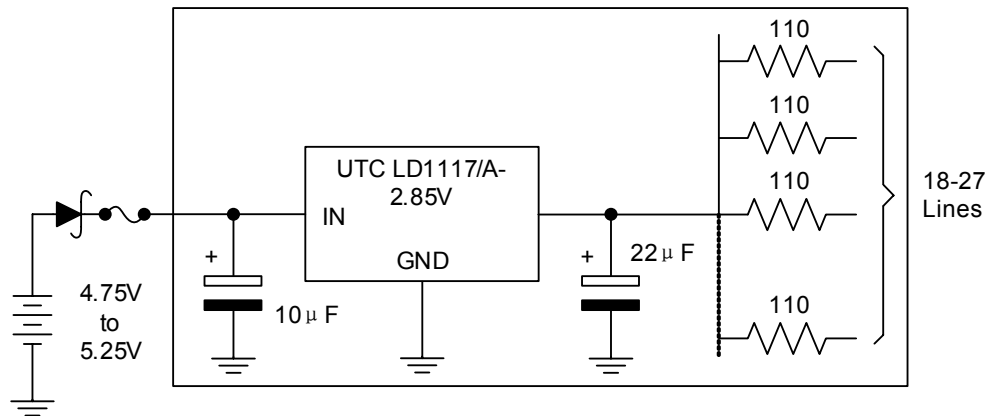


FIG.2 Active Terminator for SCSI-2 BUS

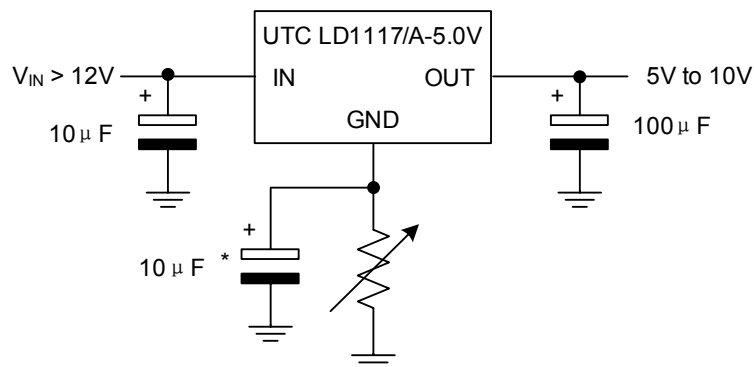


FIG.3 Circuit for Increasing Output Voltage

■ TYPICAL APPLICATIONS(Cont.)

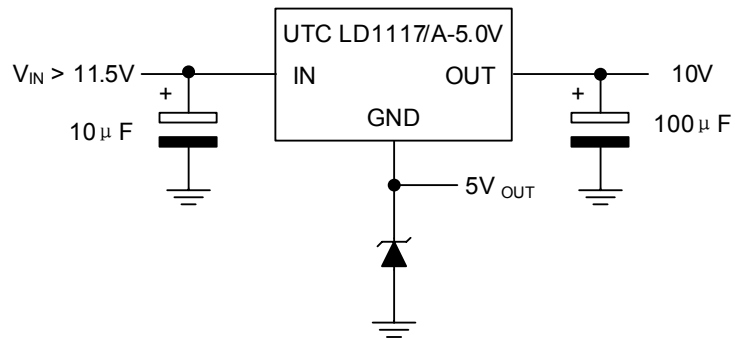


FIG.4 Voltage Regulator With Reference

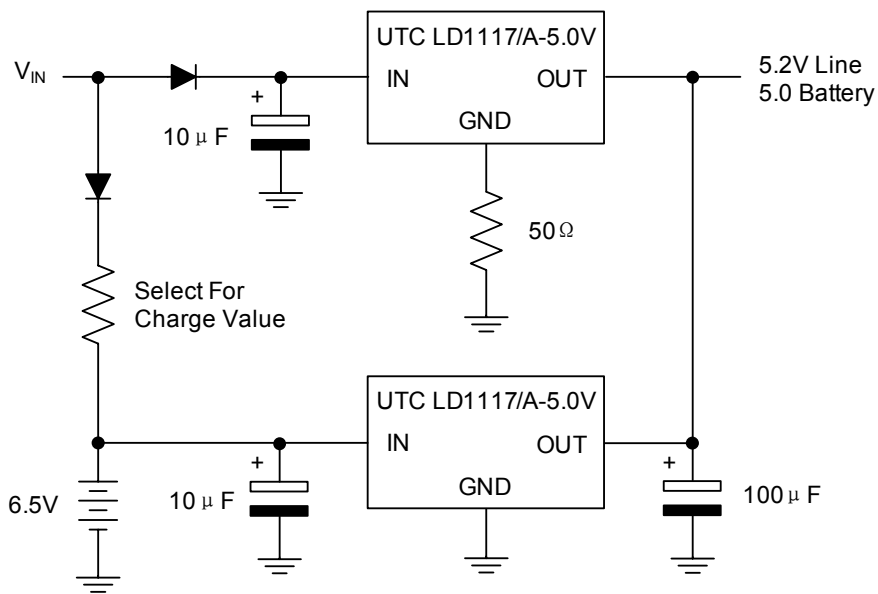


FIG.5 Battery Backed-up Regulated Supply

■ TYPICAL APPLICATIONS(Cont.)

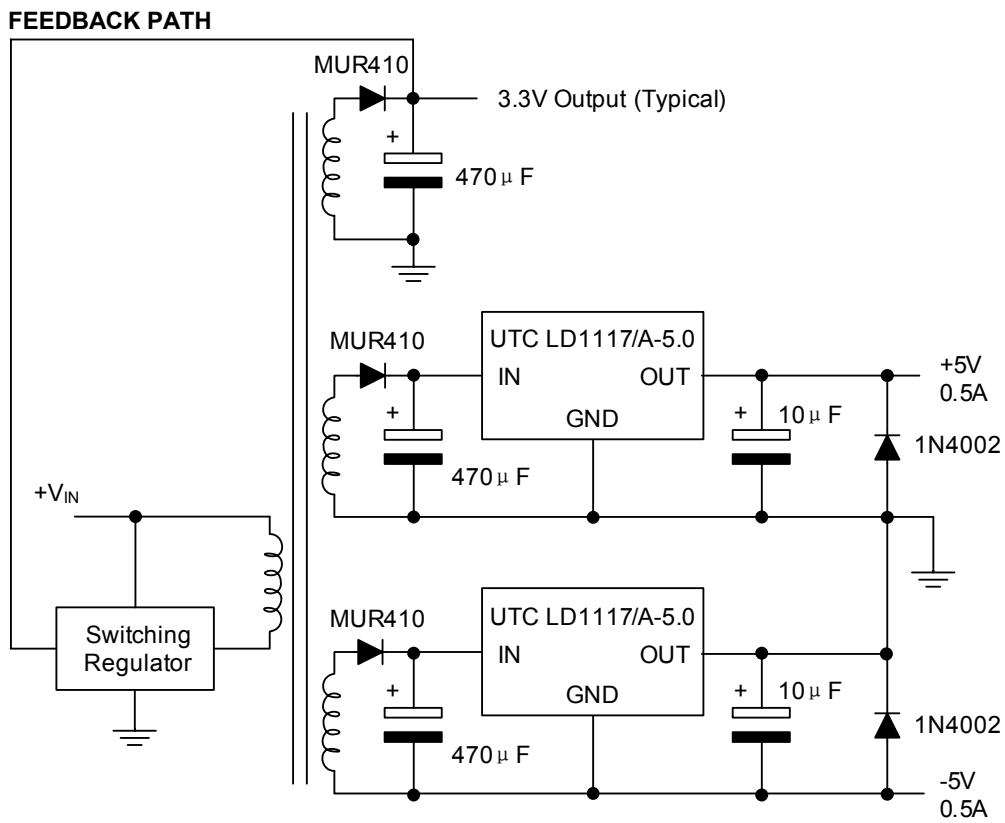


FIG.6 Post-Regulated Dual Supply

■ APPLICATION NOTE of LD1117/A ADJUSTABLE

The LD1117/A ADJUSTABLE has a thermal stabilized 1.25±0.012V reference voltage between the OUT and ADJ pins. I_{ADJ} is 60µA typ. (120µA max.) and ΔI_{ADJ} is 1µA typ. (5µA max.).

R1 is normally fixed to 120Ω. From figure 7 we obtain:

$$V_{OUT} = V_{REF} + R2(I_{ADJ} + I_{R1}) = V_{REF} + R2(I_{ADJ} + V_{REF} / R1) = V_{REF}(1 + R2/R1) + R2 \times I_{ADJ}$$

In normal application R2 value is in the range of few KΩ, so the $R2 \times I_{ADJ}$ product could not be considered in the V_{OUT} calculation; then the above expression becomes: $V_{OUT} = V_{REF}(1 + R2/R1)$

In order to have the better load regulation it is important to realize a good Kelvin connection of R1 and R2 resistors. In particular R1 connection must be realized very close to OUT and ADJ pin, while R2 ground connection must be placed as near as possible to the negative Load pin. Ripple rejection can be improved by introducing a 10µF electrolytic capacitor placed in parallel to the R2 resistor (See Fig. 8)

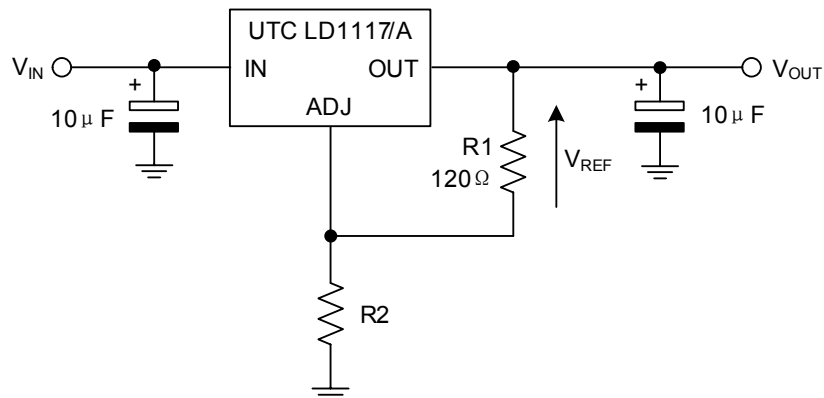


FIG.7 Adjustable Output Voltage Application Circuit

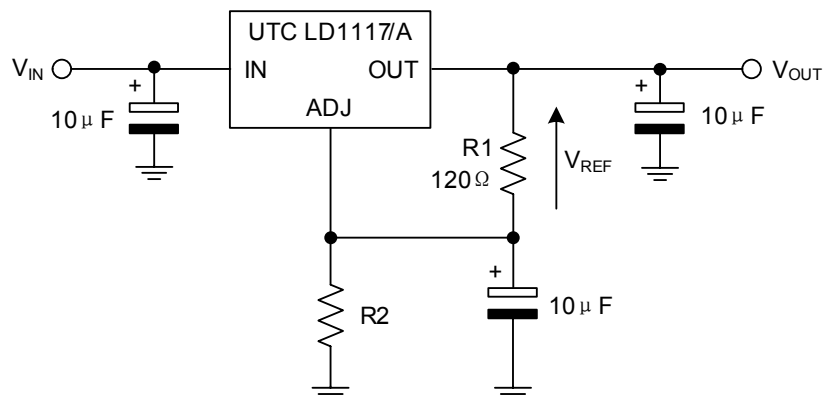


FIG.8 Adjustable Output Voltage Application with improved Ripple Rejection.

■ TYPICAL PERFORMANCE CHARACTERISTICS

Fig.1 Reference Voltage vs. Temperature

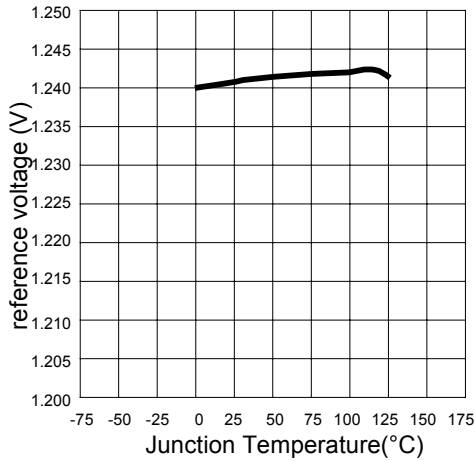


Fig.2 Output Voltage vs. Temperature

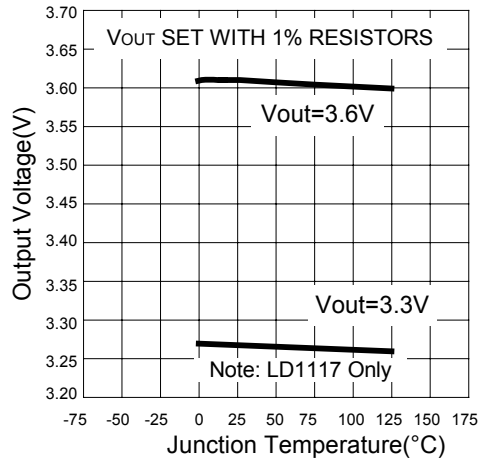
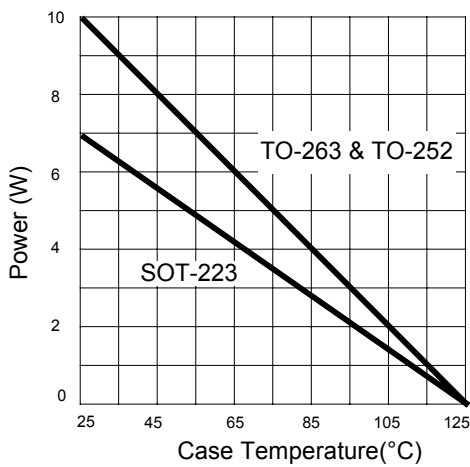


Fig.3 Maximum Power Dissipation



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